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(12) United States Design Patent

Essex et al.

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(54) **IMPEDANCE MEASUREMENT SYSTEM COMPONENT**

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(**) Term: **15 Years**

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(51) **LOC (11) Cl.** **10-04**

(52) **U.S. Cl.**
USPC **D10/94**

(58) **Field of Classification Search**
USPC D10/46, 93, 94
CPC G01G 21/28; G01G 21/283; G01G 21/286; G01G 21/30; G01G 23/37; G01G 23/3728; G01G 23/3735
See application file for complete search history.

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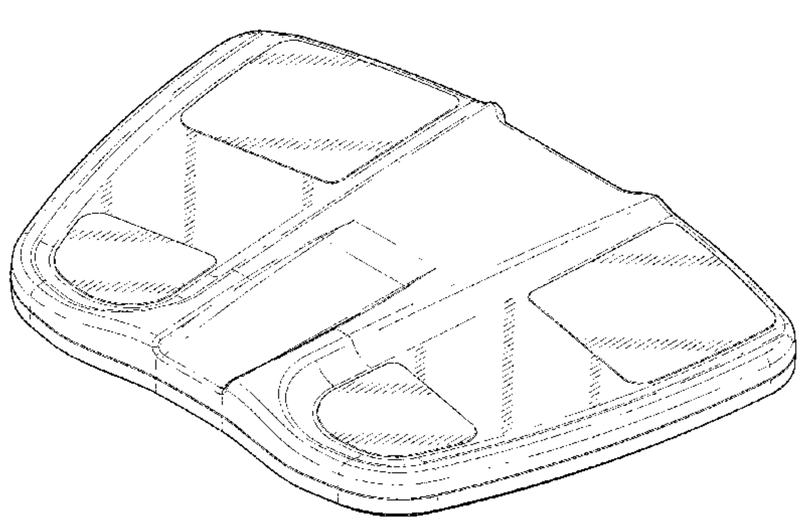
(57) **CLAIM**

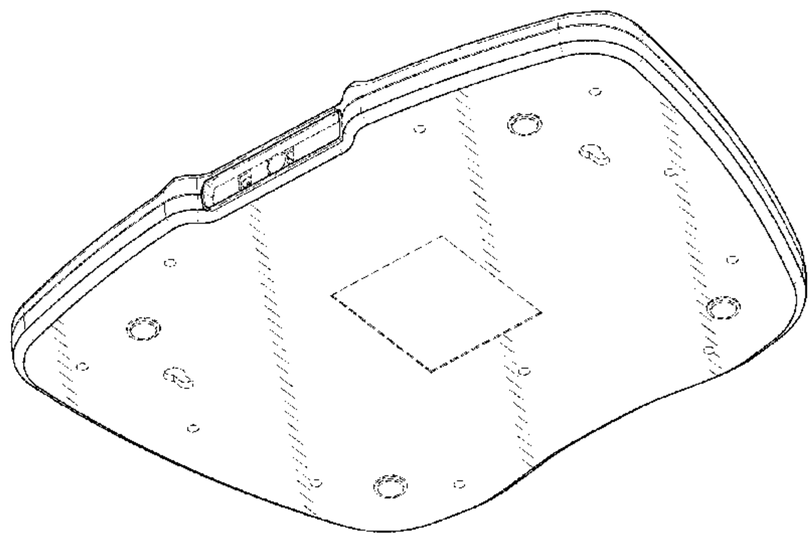
The ornamental design for an impedance measurement system component, substantially as shown and described herein.

DESCRIPTION

FIG. **1** is a front, top, and first side perspective view of a first embodiment of an impedance measurement system component embodying the new design;
FIG. **2** is a back, bottom, and second side perspective view thereof;
FIG. **3** is top view thereof;
FIG. **4** is a bottom view thereof;
FIG. **5** is a front view thereof;
FIG. **6** is a back view thereof;
FIG. **7** is a second side view thereof;
FIG. **8** is a first side view thereof;
FIG. **9** is a front, top, and first side perspective view of an alternative embodiment of a component of an impedance measurement system embodying the new design;
FIG. **10** is a back, bottom, and second side perspective view thereof;
FIG. **11** is top view thereof;
FIG. **12** is a bottom view thereof;
FIG. **13** is a front view thereof;
FIG. **14** is a back view thereof;
FIG. **15** is a second side view thereof; and,
FIG. **16** is a first side view thereof.
Broken lines are used to illustrate features of the impedance measurement system component which form no part of the claimed design. In the alternative embodiment illustrated in FIGS. **9-16**, additional features are also shown in dashed form.

1 Claim, 12 Drawing Sheets





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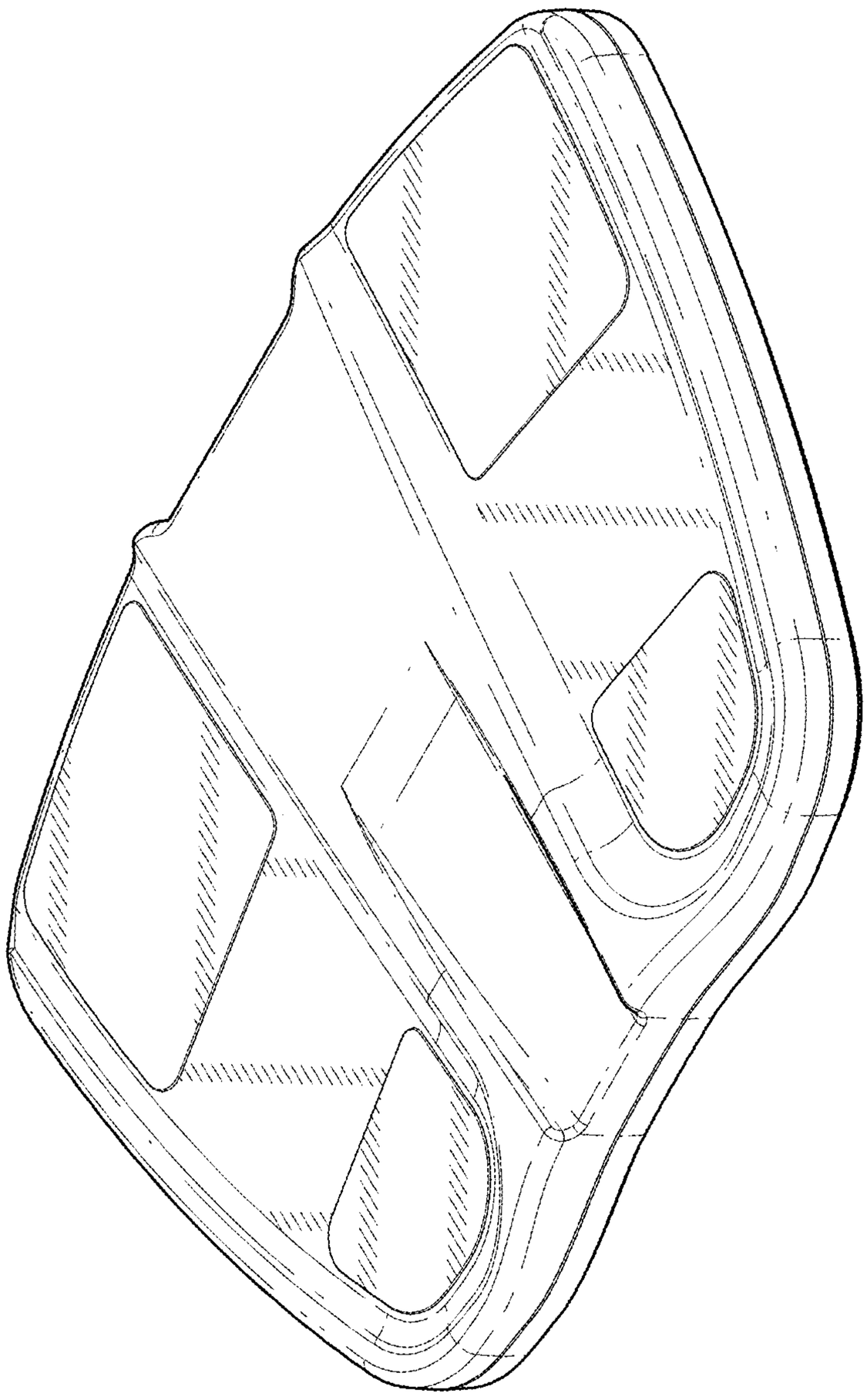


FIG. 1

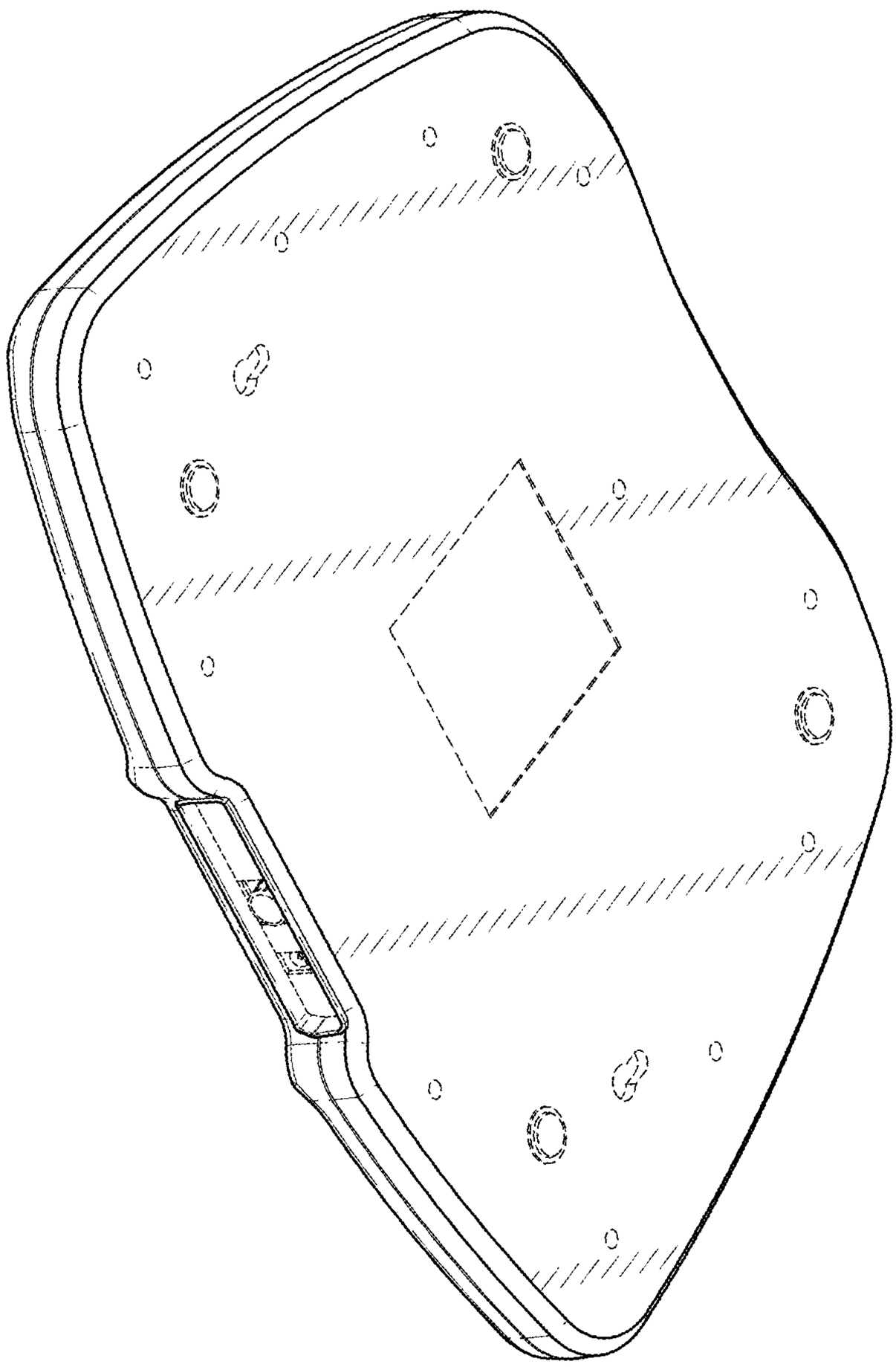
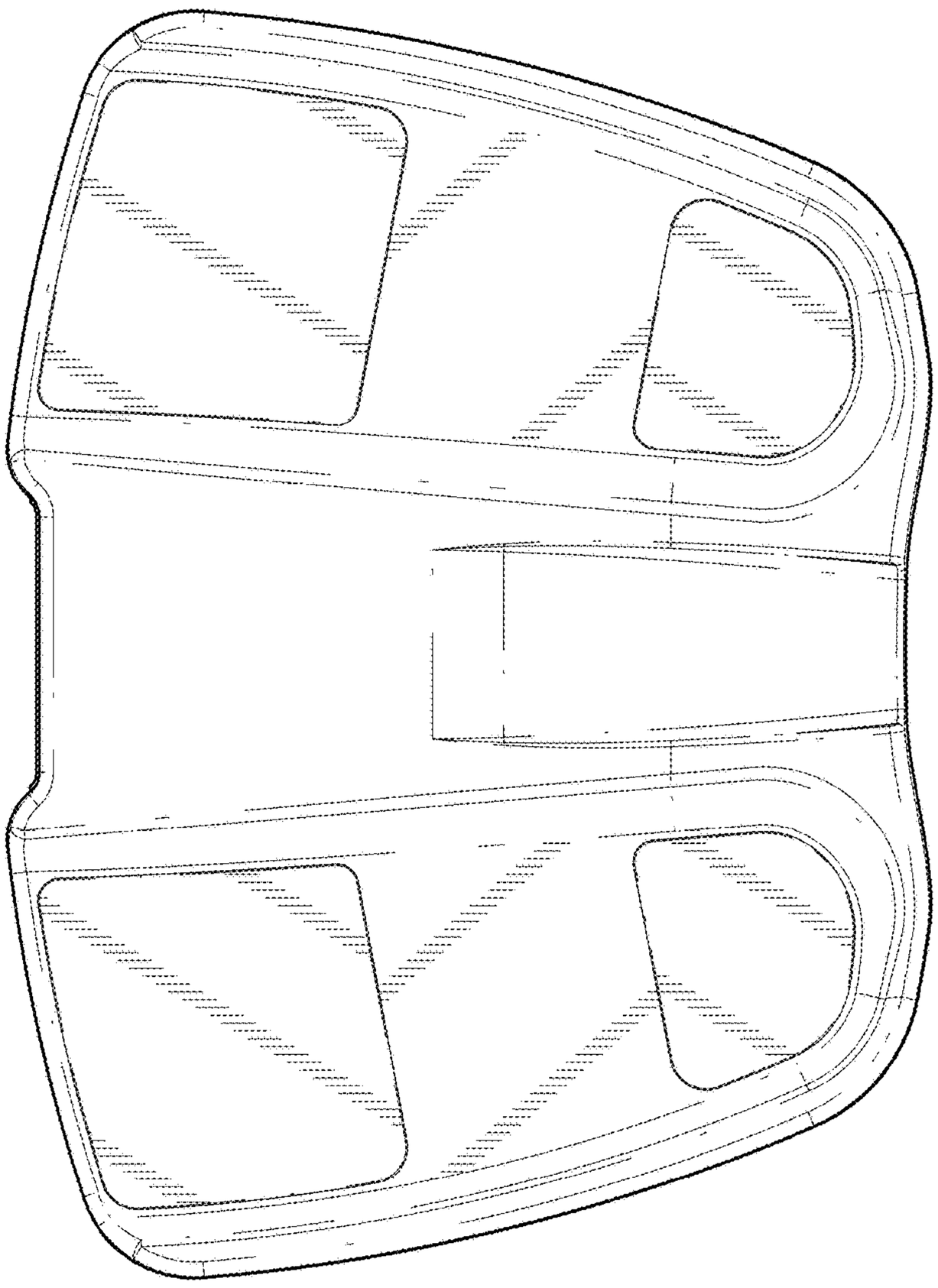


FIG. 2



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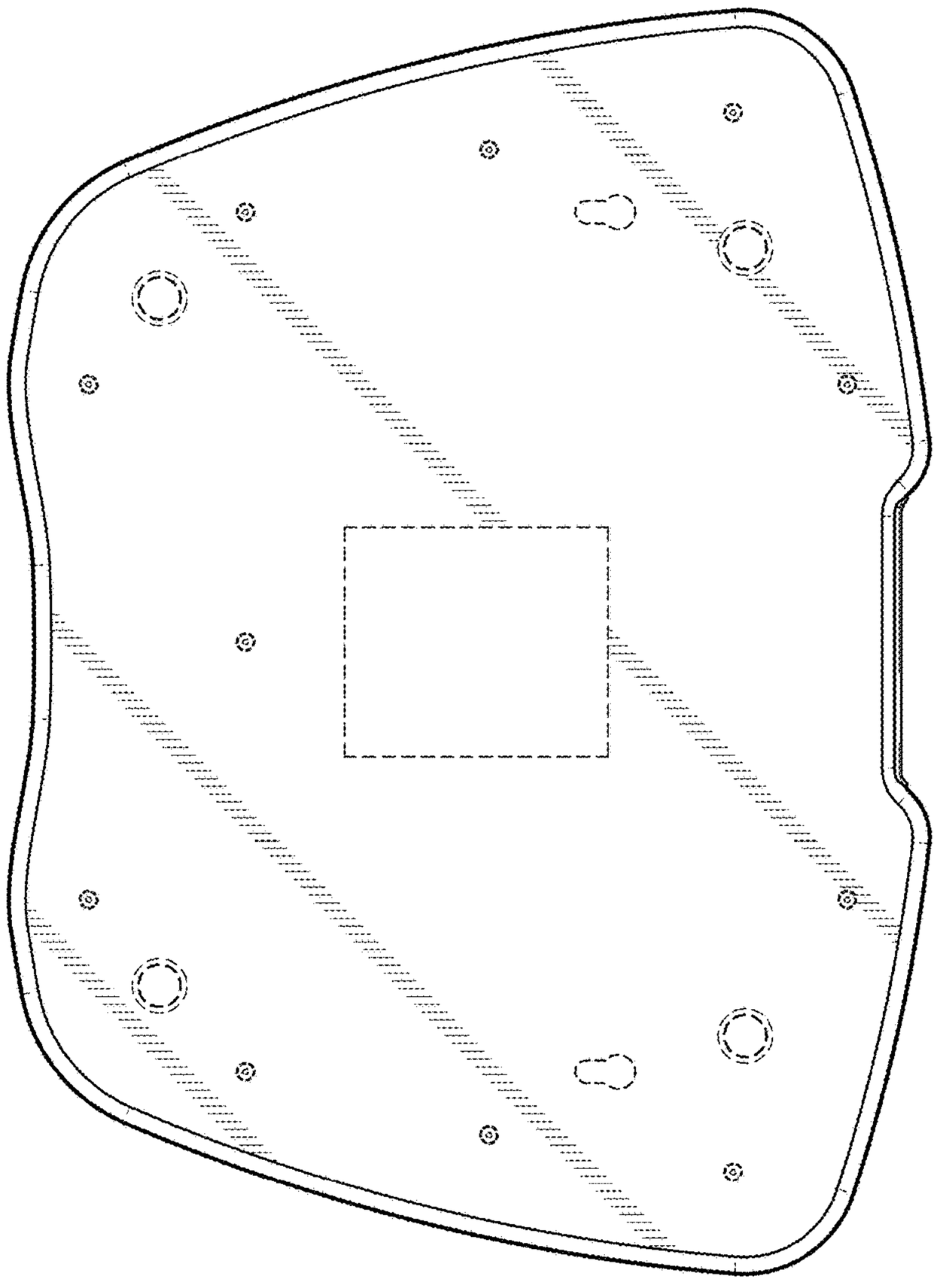

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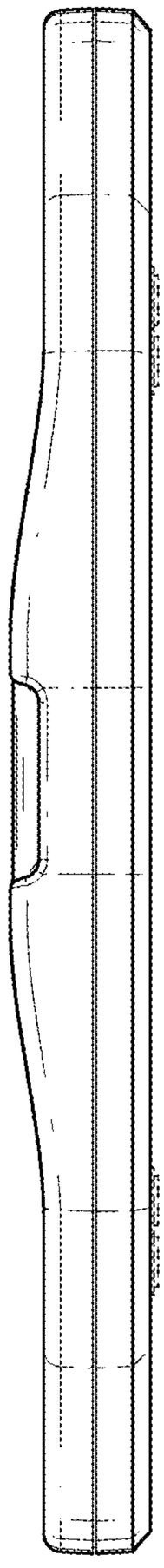

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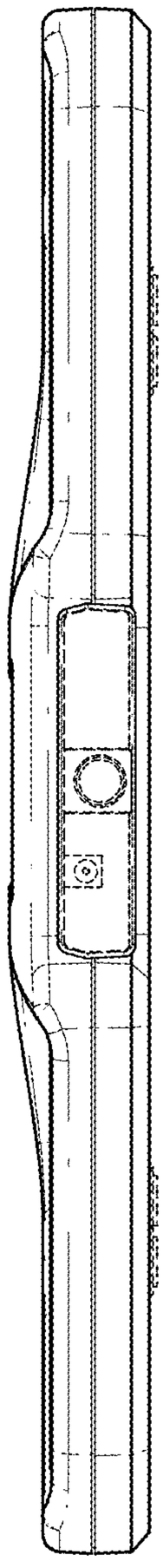

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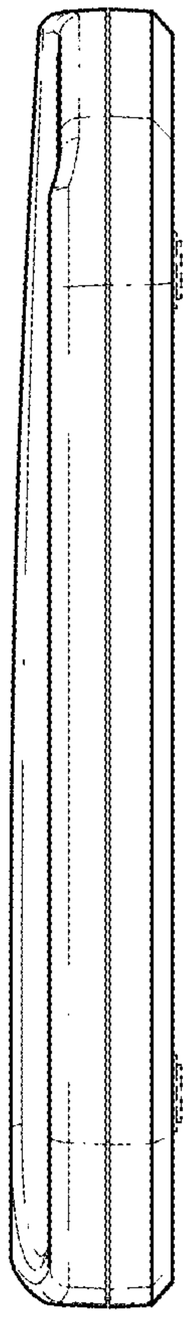

FIG. 7

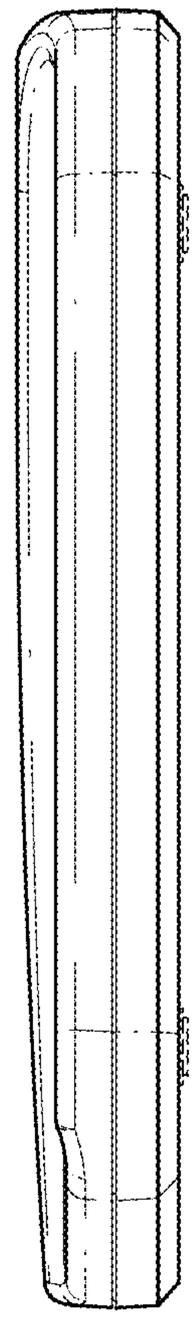

FIG. 8

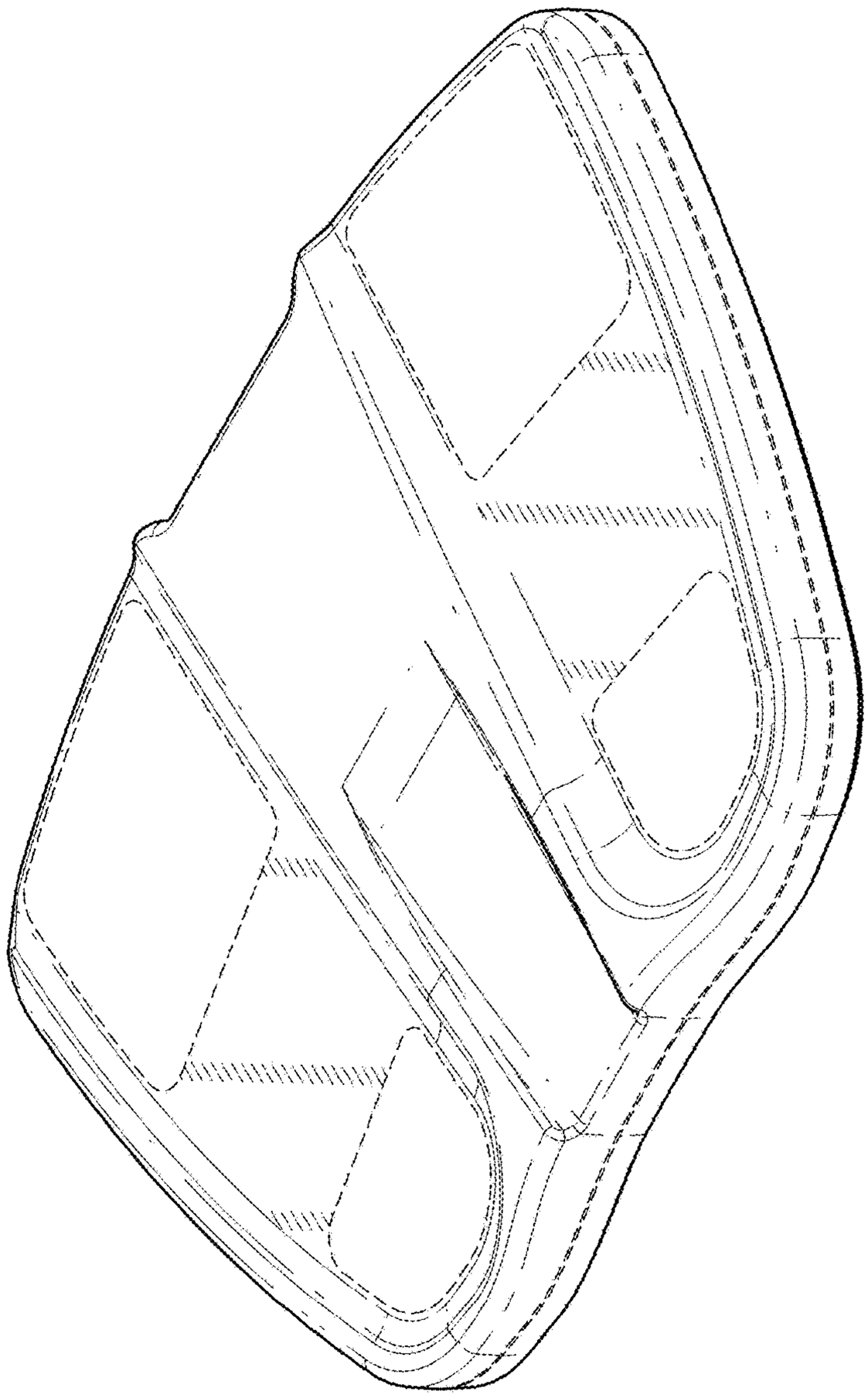

FIG. 9

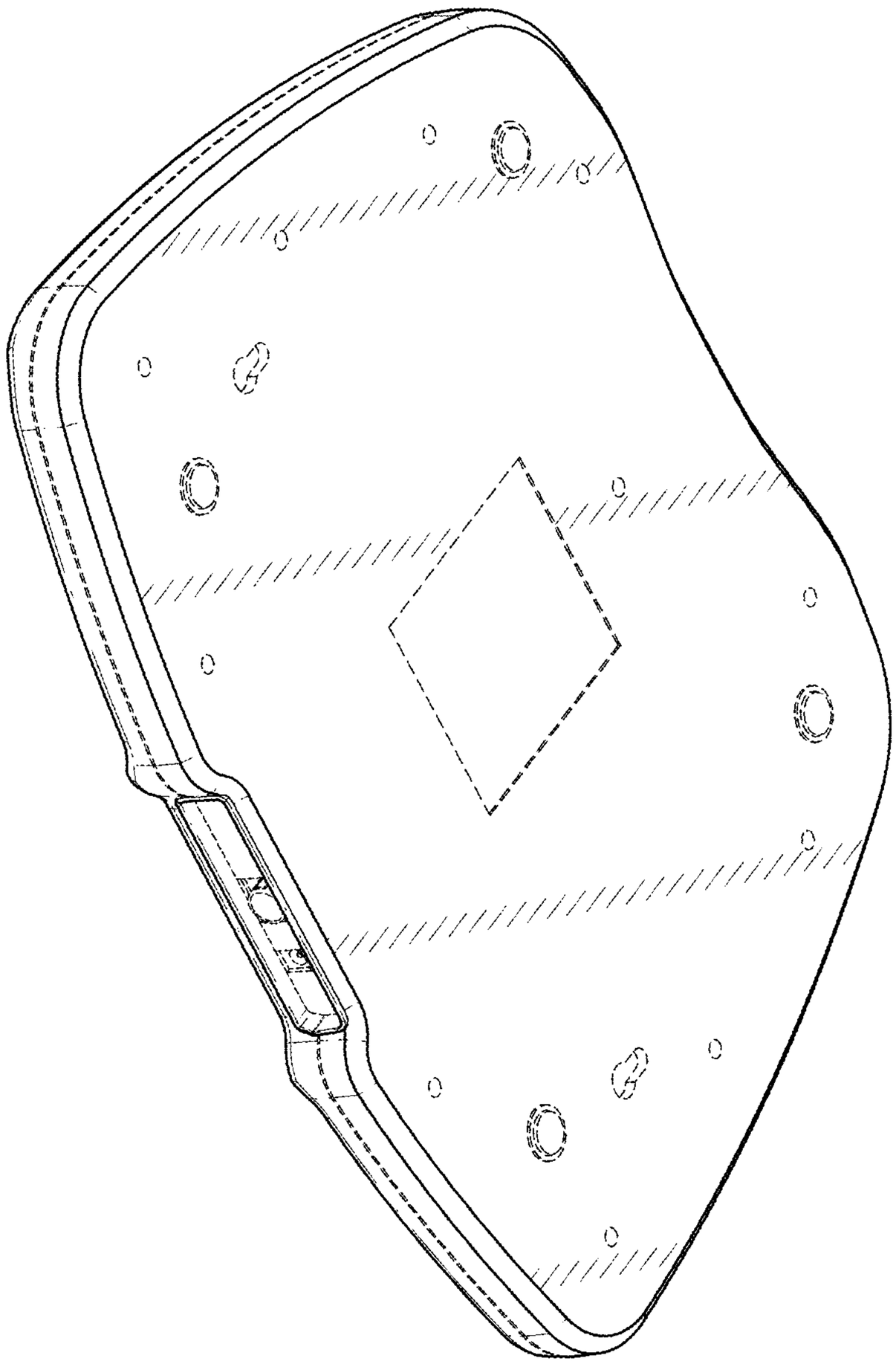

FIG. 10

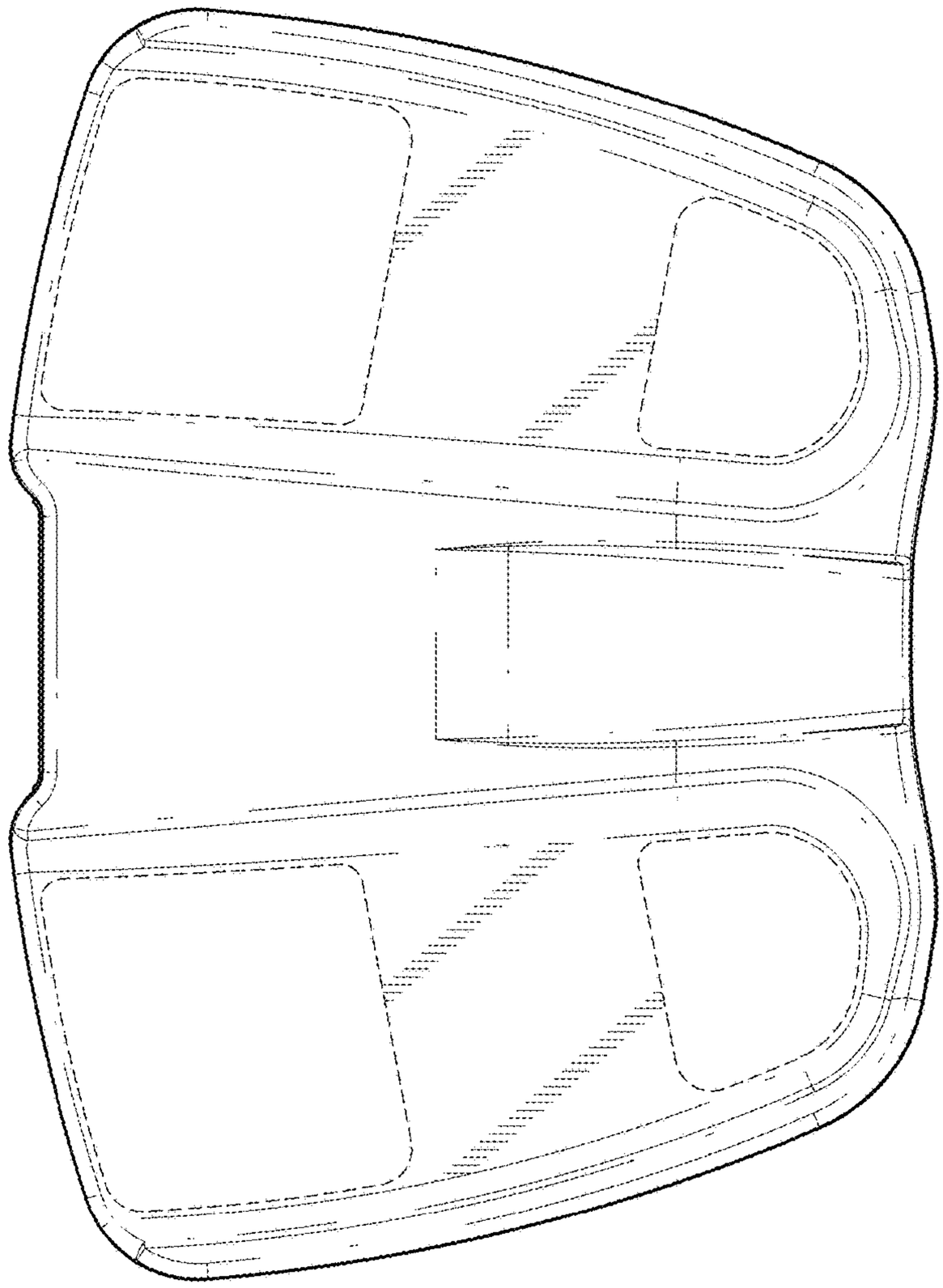

FIG. 11

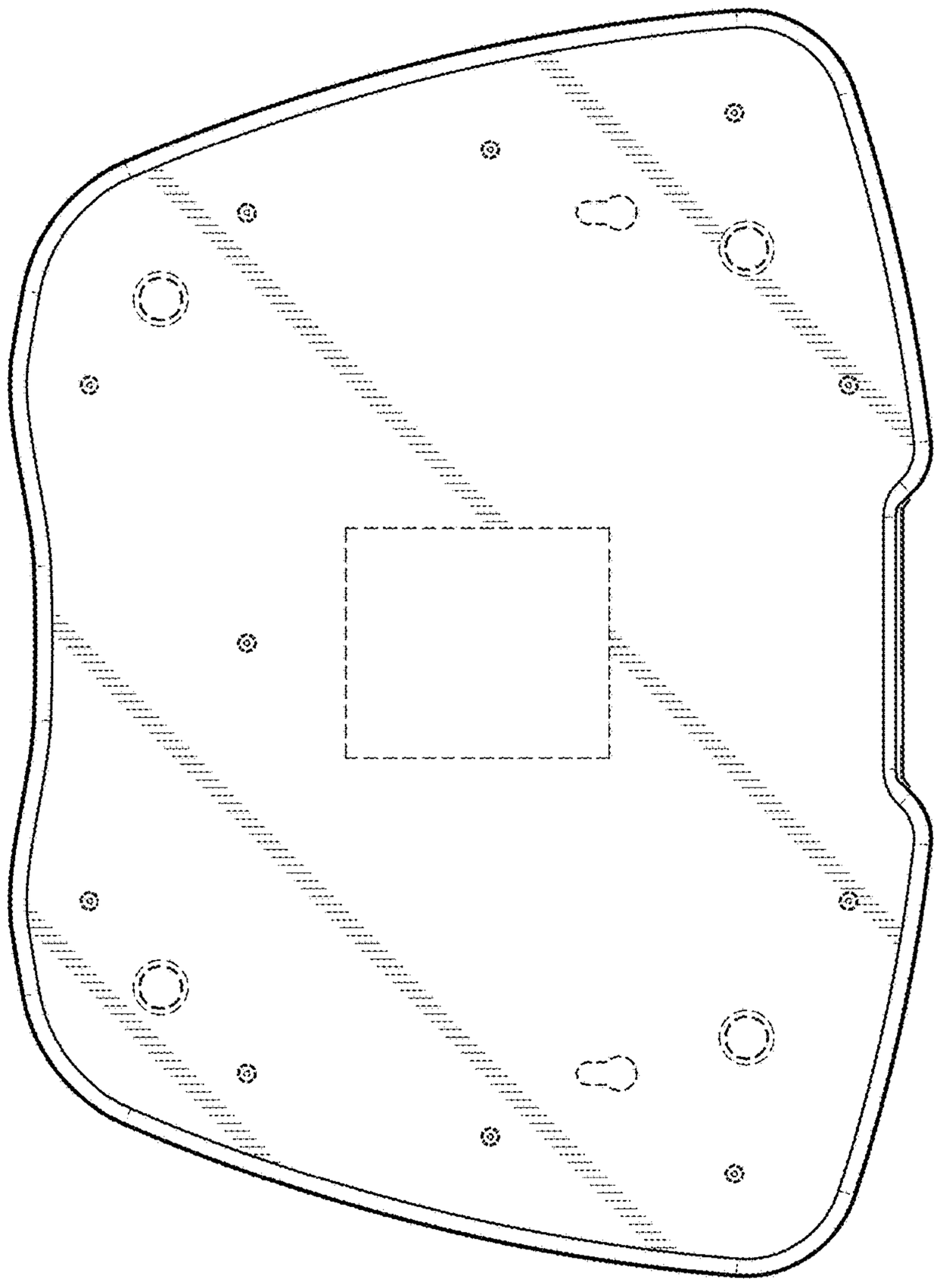

FIG. 12

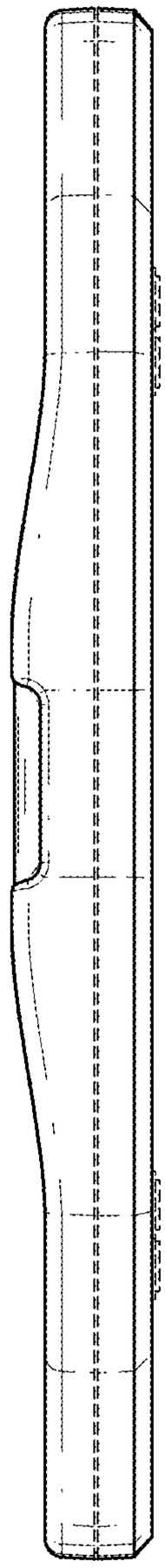

FIG. 13

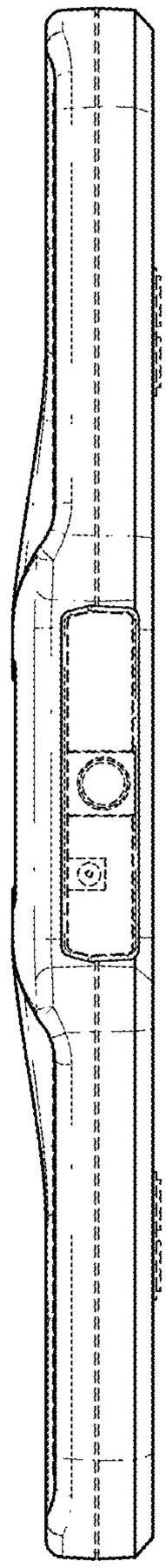

FIG. 14

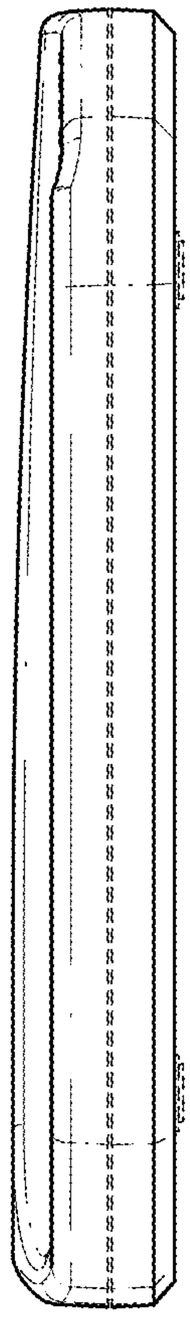

FIG. 15

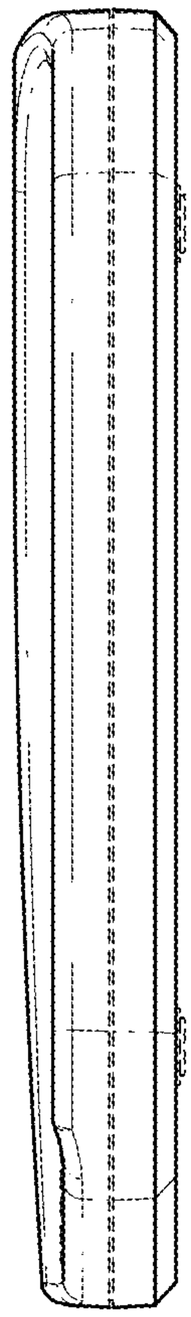

FIG. 16